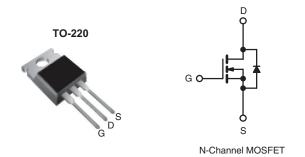


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	1000			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	5.0		
Q _g (Max.) (nC)	80			
Q _{gs} (nC)	10			
Q _{gd} (nC)	42			
Configuration	Single			



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available



DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220
Lead (Pb)-free	IRFBG30PbF
Lead (PD)-liee	SiHFBG30-E3
SnPb	IRFBG30
OIII D	SiHFBG30

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	1000	V	
Gate-Source Voltage			V _{GS}	± 20	7 v	
Continuous Drain Current		$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	3.1		
	V _{GS} at 10 V	T _C = 100 °C		2.0	Α	
Pulsed Drain Current ^a			I _{DM}	12		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	280	mJ	
Repetitive Avalanche Current ^a			I _{AR}	3.1	Α	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	1.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 55 \,^{\circ}\text{mH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = 3.1 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 3.1$ A, $dI/dt \le 80$ A/ μ s, $V_{DD} \le 600$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFBG30, SiHFBG30

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0		

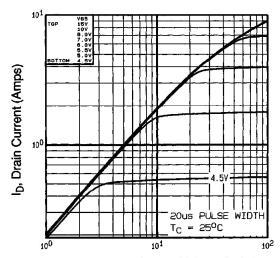
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static		<u>, </u>					
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0	1000	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		1.4	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	V _{DS} = V _{GS} , I _D = 250 μA		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	V _{DS} = 1000 V, V _{GS} = 0 V		000 V, V _{GS} = 0 V	-	-	100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 800 V, V	V _{GS} = 0 V, T _J = 125 °C	1	-	500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.9 A ^b	-	-	5.0	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 10 V, I _D = 1.9 A ^b		2.1	-	-	S
Dynamic							
Input Capacitance	C_{iss}	V _{GS} = 0 V,		i	980	-	pF
Output Capacitance	C _{oss}	V	V _{DS} = 25 V,		140	-	
Reverse Transfer Capacitance	C_{rss}	f = 1.0 MHz, see fig. 5		ı	50	-	
Total Gate Charge	Q_g		$V_{GS} = 10 \text{ V}$ $I_D = 3.1 \text{ A, } V_{DS} = 400 \text{ V, } - 100 \text{ See fig. 6 and } 13^{\text{b}}$	-	-	80	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	10	
Gate-Drain Charge	Q _{gd}			-	-	42	
Turn-On Delay Time	t _{d(on)}		1		12	-	ns
Rise Time	t _r	V_{DD} = 500 V, I_{D} = 3.1 A R_{G} = 12 Ω, R_{D} = 170 Ω, see fig. 10 ^b		-	25	-	
Turn-Off Delay Time	t _{d(off)}			-	89	-	
Fall Time	t _f			-	29	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	الم
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the	MOSFET symbol showing the		-	3.1	Α
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	12	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 3.1 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 3.1 A, dl/dt = 100 A/μs ^b		-	410	620	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.3	2.0	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

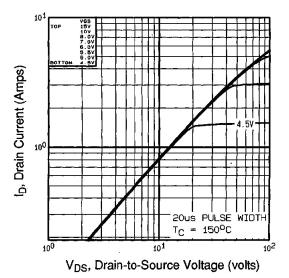


Fig. 3 - Fig. 2 - Typical Output Characteristics, T_C = 150 °C

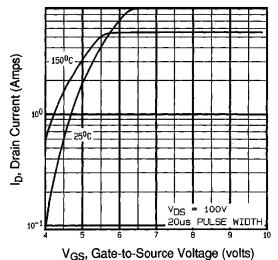


Fig. 3 - Typical Transfer Characteristics

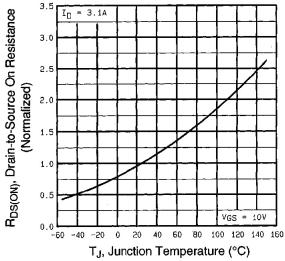
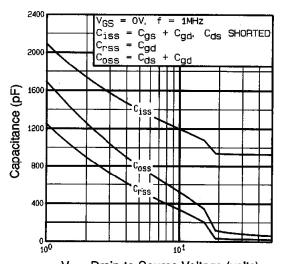


Fig. 4 - Normalized On-Resistance vs. Temperature

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V_{DS}, Drain-to-Source Voltage (volts)
Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

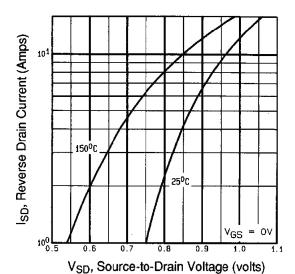


Fig. 7 - Typical Source-Drain Diode Forward Voltage

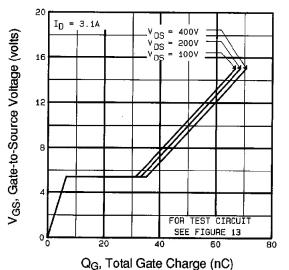


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

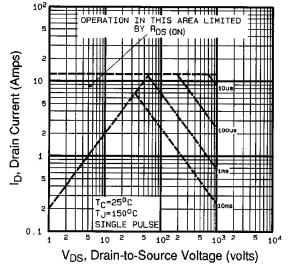
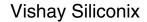


Fig. 8 - Maximum Safe Operating Area





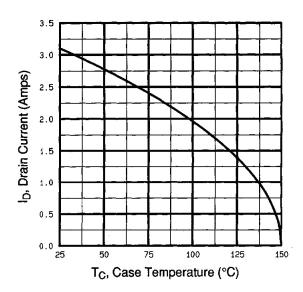


Fig. 9 - Maximum Drain Current vs. Case Temperature

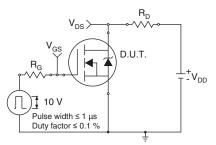


Fig. 10a - Switching Time Test Circuit

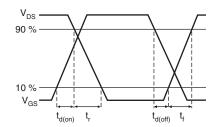


Fig. 10b - Switching Time Waveforms

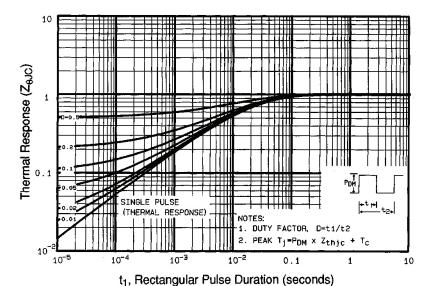


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

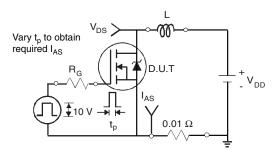


Fig. 12a - Unclamped Inductive Test Circuit

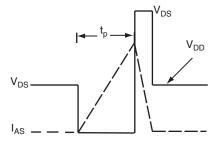


Fig. 12b - Unclamped Inductive Waveforms

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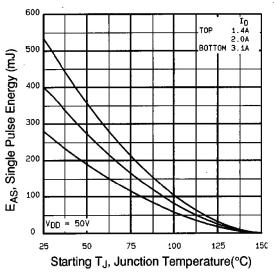


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

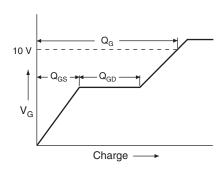


Fig. 13a - Basic Gate Charge Waveform

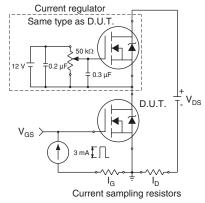
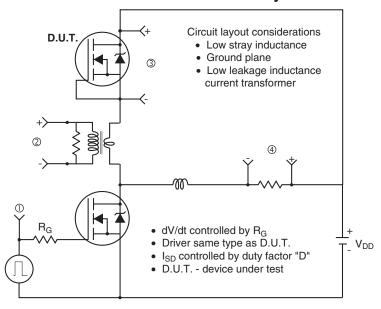
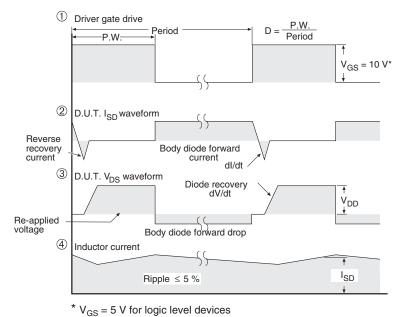


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91124.

Fig. 14 - For N-Channel





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